

Notice of References Cited	Application/Control No. 10/700,528	Applicant(s)/Patent Under Reexamination LEE ET,AL.	
	Examiner Matt P. Hodges	Art Unit 2879	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0117060 A1	06-2003	Kim et al.	313/477.00R
	B	US-2004/0000860 A1	01-2004	Jung, Sung Han	313/477.00R
	C	US-6,268,693 B1	07-2001	Miwa et al.	313/479
	D	US-2004/0239232 A1	12-2004	Baek et al.	313/477.00R
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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